

www.ti.com

800mA, Single-Input, Single Cell Li-Ion Battery Charger With Auto Start

Check for Samples: bq24040 bq24041

FEATURES

- CHARGING
 - 1% Charge Voltage Accuracy
 - 10% Charge Current Accuracy
 - Pin Selectable USB 100mA and 500mA Maximum Input Current Limit
 - Programmable Termination and Precharge Threshold, bq24040
- PROTECTION
 - 30V Input Rating; with 6.6V or 7.1V Input Overvoltage Protection
 - Input Voltage Dynamic Power Management
 - 125°C Thermal Regulation; 150°C Thermal Shutdown Protection
 - OUT Short-Circuit Protection and ISET short detection
 - Operation over JEITA Range via Battery NTC – 1/2 Fast-Charge-Current at Cold, 4.06V at Hot, bq24040

- Fixed 10 Hour Safety Timer
- SYSTEM
 - Automatic Termination and Timer Disable Mode (TTDM) for Absent Battery Pack With Thermistor, bq24040
 - Status Indication Charging/Done
 - Available in Small 2×2mm² DFN-10 Package
 - Integrated Auto Start Function for Production Line Testing, bq24041

APPLICATIONS

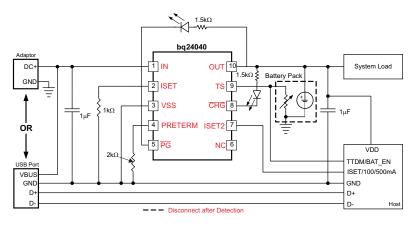
- Smart Phones
- PDAs
- MP3 Players
- Low-Power Handheld Devices

DESCRIPTION

The bq2404x series of devices are highly integrated Li-ion linear chargers devices targeted at space-limited portable applications. The devices operate from either a USB port or AC adapter. The high input voltage range with input overvoltage protection supports low-cost unregulated adapters.

The bq2404x has a single power output that charges the battery. A system load can be placed in parallel with the battery as long as the average system load does not keep the battery from charging fully during the 10 hour safety timer.

The battery is charged in three phases: conditioning, constant current and constant voltage. In all charge phases, an internal control loop monitors the IC junction temperature and reduces the charge current if an internal temperature threshold is exceeded.





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

bg24040 ba24041 SL参約AB 在FTEMBER 2009





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION CONTINUED

The charger power stage and charge current sense functions are fully integrated. The charger function has high accuracy current and voltage regulation loops, charge status display, and charge termination. The pre-charge current and termination current threshold are programmed via an external resistor on the bg24040. The fast charge current value is also programmable via an external resistor.

PART # ASI/ASO TS/BAT PACKAGE PreTerm PG Marking V_{O(REG)} VOVP EN 4.20 V 10 PIN 2 x 2mm² DFN bq24040 6.6 V Yes No TS Yes NXE bq24041 4.20 V 7.1 V Yes BAT EN Yes 10 PIN 2 x 2mm² DFN NXF No

ORDERING INFORMATION

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

				VALUE	UNIT		
		IN (with respect to VS	IN (with respect to VSS) OUT (with respect to VSS)				
	Input Voltage	OUT (with respect to					
	input voltago	PRE-TERM, ISET, IS (with respect to VSS)	-0.3 to 7	V			
	Input Current	IN		1.25	А		
	Output Current (Continuous)	OUT		1.25	А		
	Output Sink Current	CHG		15	mA		
ESD	Electrostatic discharge (IEC61000-4-2) ⁽²⁾	IN, OUT, TS	1μF between IN and GND, 1μF between TS and GND, 2μF between OUT and GND, x5R Ceramic or equivalent	8 contact 15 Air	kV		
TJ	Junction temperature			-40 to 150	°C		
T _{STG}	Storage temperature			-65 to 150	°C		

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to the network ground terminal unless otherwise noted.

The test was performed on IC pins that may potentially be exposed to the customer at the product level. The bq2404x IC requires a (2) minimum of the listed capacitance, external to the IC, to pass the ESD test. The D+ D- lines require clamp diodes such as CM1213A-02SR from CMD to protect the IC for this testing.

PACKAGE DISSIPATION RATINGS⁽¹⁾ ⁽²⁾

PACKAGE	R _{0JA}	R _{θJC}	T _A ≤ 25°C POWER RATING	DERATING FACTOR T _A > 25°C
$2 \times 2 \text{ mm}^2 \text{ DFN}$	60°C/W	8.8°C/W	1.66W	16.6mW/°C

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com.

This data is based on using the JEDEC High-K board and the exposed die pad is connected to a copper pad on the board. This is (2)connected to the ground plane by a 2x3 via matrix

RECOMMENDED OPERATING CONDITIONS⁽¹⁾

		MIN	NOM	UNIT
V	IN voltage range	3.5	28	V
V _{IN}	IN operating voltage range, Restricted by $V_{\mbox{\scriptsize DPM}}$ and $V_{\mbox{\scriptsize OVP}}$	4.45	6.45	V
I _{IN}	Input current, IN pin		0.8	А
I _{OUT}	Current, OUT pin		0.8	А
TJ	Junction temperature	0	125	°C
R _{PRE-TERM}	Programs precharge and termination current thresholds	1	10	kΩ
R _{ISET}	Fast-charge current programming resistor	0.675	49.9	kΩ
R _{TS}	10k NTC thermistor range without entering BAT_EN or TTDM	1.66	258	kΩ

(1) Operation with V_{IN} less than 4.5V or in drop-out may result in reduced performance.

ELECTRICAL CHARACTERISTICS

Over junction temperature range $0^{\circ}C \le T_{J} \le 125^{\circ}C$ and recommended supply voltage (unless otherwise noted)

Undervoltage lock-out Exit Hysteresis on $V_{UVLO_{RISE}}$ falling Input power good detection threshold is $V_{OUT} + V_{IN-DT}$ Hysteresis on V_{IN-DT} falling	$ \begin{array}{l} V_{\text{IN}}: 0V \rightarrow 4V \text{ Update based on sim/char} \\ V_{\text{IN}}: 4V \rightarrow 0V, \\ V_{\text{UVL0_FALL}} = V_{\text{UVL0_RISE}} - V_{\text{HYS-UVL0}} \\ \text{(Input power good if } V_{\text{IN}} > V_{\text{OUT}} + V_{\text{IN-DT}}\text{)}; V_{\text{OUT}} = \\ 3.6V, V_{\text{IN}}: 3.5V \rightarrow 4V \end{array} $	3.15 175	3.3 227	3.45 280	V
Hysteresis on $V_{UVLO_{RISE}}$ falling Input power good detection threshold is $V_{OUT} + V_{IN-DT}$	$V_{IN}: 4V \rightarrow 0V,$ $V_{UVL0_FALL} = V_{UVL0_RISE} - V_{HYS-UVLO}$ (Input power good if $V_{IN} > V_{OUT} + V_{IN-DT}$); $V_{OUT} =$	175			-
Input power good detection threshold is $V_{OUT} + V_{IN-DT}$	$V_{UVLO_FALL} = V_{UVLO_RISE} - V_{HYS-UVLO}$ (Input power good if $V_{IN} > V_{OUT} + V_{IN-DT}$); $V_{OUT} =$		227	280	
is V _{OUT} + V _{IN-DT}	(Input power good if $V_{IN} > V_{OUT} + V_{IN-DT}$); $V_{OUT} =$				mV
Hysteresis on VIN-DT falling	$3.0^{\circ}, ^{\circ}_{\text{IN}}, 3.5^{\circ} \rightarrow 4^{\circ}$	30	80	145	mV
,	$V_{OUT} = 3.6 \text{V}, \text{V}_{\text{IN}} : 4 \text{V} \rightarrow 3.5 \text{V}$		31		mV
Deglitch time on exiting sleep.	Time measured from V_{IN}: 0V \rightarrow 5V 1µs rise-time to \overline{PG} = low, V_{OUT} = 3.6V		45		μs
Deglitch time on V _{HYS-INDT} power down. Same as entering sleep.	Time measured from V_{IN}: 5V \rightarrow 3.2V 1µs fall-time to \overline{PG} = OC, V_{OUT} = 3.6V		29		ms
Input over veltage protection threshold	V_{IN} : 5V \rightarrow 12V (bq24040)	6.5	6.65	6.8	V
input over-voltage protection threshold	V_{IN} : 5V \rightarrow 12V (bq24041)	6.9	7.1	7.3	v
Input over-voltage blanking time	V_{IN} : 5V \rightarrow 12V		113		μs
Hysteresis on OVP	V_{IN} : 11V \rightarrow 5V		95		mV
Deglitch time exiting OVP	Time measured from $V_{IN}\!\!:12V\to5V$ 1µs fall-time to \overline{PG} = LO		30		μs
	Feature active in USB mode; Limit Input Source Current to 50mA; V_{OUT} =3.5V; R_{ISET} = 825 Ω	4.34	4.4	4.46	
protection. Restricts lout at V _{IN-DPM}	Feature active in Adaptor mode; Limit Input Source Current to 50mA; V_{OUT} =3.5V; R_{ISET} = 825 Ω	4.24	4.3	4.36	V
USB input I-Limit 100mA	ISET2 = Float; $R_{ISET} = 825\Omega$	85	92	100	
USB input I-Limit 500mA, bq24040	ISET2 = High; $R_{ISET} = 825\Omega$	430	462	500	mA
USB input I-Limit 380mA, bq24041	ISET2 = High; $R_{ISET} = 825\Omega$	350	386	420	
Highest Resistor value considered a fault (short). Monitored for lout>90mA	Riset: $600\Omega \rightarrow 250\Omega$, lout latches off. Cycle power to Reset.	280		500	Ω
Deglitch time transition from ISET short to lout disable	Clear fault by cycling IN or TS/BAT_EN		1		ms
Maximum OUT current limit Regulation (Clamp)	$V_{IN} = 5V, V_{OUT} = 3.6V, V_{ISET2} = Low, Riset: 600\Omega$ $\rightarrow 250\Omega$, lout latches off after t _{DGL-SHORT}	1.05		1.4	А
	Hysteresis on V _{IN-DT} falling Deglitch time on exiting sleep. Deglitch time on V _{HYS-INDT} power down. Same as entering sleep. Input over-voltage protection threshold Input over-voltage blanking time Hysteresis on OVP Deglitch time exiting OVP USB/Adaptor low input voltage protection. Restricts lout at V _{IN-DPM} USB input I-Limit 100mA USB input I-Limit 500mA, bq24040 USB input I-Limit 380mA, bq24041 IRCUIT TEST Highest Resistor value considered a fault (short). Monitored for lout>90mA Deglitch time transition from ISET short to lout disable Maximum OUT current limit Regulation	Hysteresis on VIN-DT falling $V_{OUT} = 3.6V, V_{IN}: 4V \rightarrow 3.5V$ Deglitch time on exiting sleep.Time measured from $V_{IN}: 0V \rightarrow 5V$ 1µs rise-time to $\overline{PG} = low, V_{OUT} = 3.6V$ Deglitch time on exiting sleep.Time measured from $V_{IN}: 5V \rightarrow 3.2V$ 1µs fall-time to $\overline{PG} = OC, V_{OUT} = 3.6V$ Input over-voltage protection threshold $V_{IN}: 5V \rightarrow 12V$ (bq24040)Input over-voltage blanking time $V_{IN}: 5V \rightarrow 12V$ (bq24041)Input over-voltage blanking time $V_{IN}: 5V \rightarrow 12V$ Hysteresis on OVP $V_{IN}: 11V \rightarrow 5V$ Deglitch time exiting OVPTime measured from $V_{IN}: 12V \rightarrow 5V$ 1µs fall-time to $\overline{PG} = LO$ USB/Adaptor low input voltage protection. Restricts lout at V_{IN-DPM} Feature active in USB mode; Limit Input Source Current to 50mA; $V_{OUT}=3.5V$; $R_{ISET} = 825\Omega$ USB input I-Limit 100mAISET2 = Float; $R_{ISET} = 825\Omega$ USB input I-Limit 380mA, bq24040ISET2 = High; $R_{ISET} = 825\Omega$ USB input I-Limit 380mA, bq24041ISET2 = High; $R_{ISET} = 825\Omega$ Highest Resistor value considered a fault (short). Monitored for lout-90mARiset: 600\Omega $\rightarrow 250\Omega$, lout latches off. Cycle power to Reset.Deglitch time transition from ISET short to lout disableClear fault by cycling IN or TS/BAT_ENMaximum OUT current limit Regulation $V_{IN} = 5V, V_{OUT} = 3.6V, V_{ISET2} = Low, Riset: 600\Omega$	Hysteresis on V_{IN-DT falling $V_{OUT} = 3.6V, V_{IN}: 4V \rightarrow 3.5V$ Deglitch time on exiting sleep.Time measured from $V_{IN}: 0V \rightarrow 5V$ 1µs rise-time to $\overline{PG} = low, V_{OUT} = 3.6V$ Deglitch time on V_HYS-INDT power down. Same as entering sleep.Time measured from $V_{IN}: 5V \rightarrow 3.2V$ 1µs fall-time to $\overline{PG} = 0C, V_{OUT} = 3.6V$ Input over-voltage protection threshold $V_{IN}: 5V \rightarrow 12V$ (bq24040)6.5Input over-voltage blanking time $V_{IN}: 5V \rightarrow 12V$ (bq24041)6.9Hysteresis on OVP $V_{IN}: 5V \rightarrow 12V$ Hysteresis on OVPUSB/Adaptor low input voltage protection. Restricts lout at V_{IN-DPM} Time measured from $V_{IN}: 12V \rightarrow 5V$ 1µs fall-time to $\overline{PG} = LO$ USB input I-Limit 100mAISET2 = Float; $R_{ISET} = 825\Omega$ 4.34USB input I-Limit 500mA, bq24040ISET2 = High; $R_{ISET} = 825\Omega$ 430USB input I-Limit 380mA, bq24041ISET2 = High; $R_{ISET} = 825\Omega$ 350IRCUIT TESTHighest Resistor value considered a fault (short). Monitored for lout>90mARiset: $600\Omega \rightarrow 250\Omega$, lout latches off. Cycle power to Reset.280Deglitch time transition from ISET short to lout disableClear fault by cycling IN or TS/BAT_EN280	Hysteresis on VIN-DT fallingVOLT = 3.6V, VIN: 4V \rightarrow 3.5V31Deglitch time on exiting sleep.Time measured from VIN: 0V \rightarrow 5V 1µs rise-time to PG = low, VOLT = 3.6V45Deglitch time on VINSINDT power down. Same as entering sleep.Time measured from VIN: 5V \rightarrow 3.2V 1µs fall-time to PG = 0C, VOLT = 3.6V29Input over-voltage protection thresholdVIN: 5V \rightarrow 12V (bq24040)6.56.65Input over-voltage blanking timeVIN: 5V \rightarrow 12V (bq24041)6.97.1Input over-voltage blanking timeVIN: 5V \rightarrow 12V (bq24041)6.97.1Hysteresis on OVPVIN: 11V \rightarrow 5V95Deglitch time exiting OVPTime measured from VIN: 12V \rightarrow 5V 1µs fall-time to PG = LO30USB/Adaptor low input voltage protection. Restricts lout at VIN-DPMFeature active in USB mode; Limit Input Source Current to 50mA; VOLT=3.5V; RISET = 825Ω4.344.4USB input I-Limit 100mAISET2 = Float; RISET = 825Ω8592USB input I-Limit 380mA, bq24040ISET2 = Float; RISET = 825Ω430462USB input I-Limit 380mA, bq24041ISET2 = High; RISET = 825Ω350386IRCUIT TESTHighest Resistor value considered a fault (short). Monitored for lout>90mARiset: 600Ω \rightarrow 250Ω, lout latches off. Cycle power to Reset.280Deglitch time transition from ISET short to lout disableVIN = 5V, VOLT = 3.6V, VINET = Low, Riset: 600Ω1.05	Hysteresis on VIN-DT fallingVOLT = 3.6V, VIN: 4V \rightarrow 3.5V31Deglitch time on exiting sleep.Time measured from VIN: 0V \rightarrow 5V 1µs rise-time to PG = low, VOLT = 3.6V45Deglitch time on VHYS-INDT power down. Same as entering sleep.Time measured from VIN: 5V \rightarrow 3.2V 1µs fall-time to PG = 0C, VOLT = 3.6V29Input over-voltage protection thresholdVIN: 5V \rightarrow 12V (bq24040)6.56.656.8VN: 5V \rightarrow 12V (bq24041)6.97.17.3Input over-voltage blanking timeVIN: 5V \rightarrow 12V (bq24041)6.97.17.3Hysteresis on OVPVIN: 5V \rightarrow 12V (bq24041)6.97.17.3USB/Adaptor low input voltage protection. Restricts lout at VIN-DFMTime measured from VIN: 12V \rightarrow 5V 1µs fall-time to PG = LO30USB/Adaptor low input voltage protection. Restricts lout at VIN-DFMFeature active in USB mode; Limit Input Source Current to 50mA; VOLT=3.5V; RISET = 825Ω4.344.44.46USB input I-Limit 100mAISET2 = Float; RISET = 825Ω8592100USB input I-Limit 300mA, bq24040ISET2 = High; RISET = 825Ω4.30462500USB input I-Limit 300mA, bq24041ISET2 = High; RISET = 825Ω350366420IRCUIT TESTHighest Resistor value considered a fault (short). Monitored for Iout>90mARiset: 600 \rightarrow 250 $,$ lout latches off. Cycle power to Reset.280500Deglitch time transition from ISET short to lout disableClear fault by cycling IN or TS/BAT_EN1Maximum OUT current limit RegulationVIN = 5V, VIN = 3.6V, VIN = 2.6

SL整制AB發現W時及3997-FTMBER 2009

Instruments

Texas

www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

Over junction temperature range $0^{\circ}C \le T_{J} \le 125^{\circ}C$ and recommended supply voltage (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
BATTERY SH	ORT PROTECTION					
V _{OUT(SC)}	OUT pin short-circuit detection threshold/ precharge threshold	Vout:3V \rightarrow 0.5V, no deglitch	0.75	0.8	0.85	V
V _{OUT(SC-HYS)}	OUT pin Short hysteresis	Recovery $\ge V_{OUT(SC)} + V_{OUT(SC-HYS)}$; Rising, no Deglitch		77		mV
I _{OUT(SC)}	Source current to OUT pin during short-circuit detection		10	15	20	mA
QUIESCENT	CURRENT	· · · · · · · · · · · · · · · · · · ·				
I _{OUT(PDWN)}	Battery current into OUT pin	V _{IN} = 0V			1	•
I _{OUT(DONE)}	OUT pin current, charging terminated	$V_{IN} = 6V, V_{OUT} > V_{OUT(REG)}$			6	μA
IIN(STDBY)	Standby current into IN pin	$TS = LO, V_{IN} \le 6V$			125	μA
I _{CC}	Active supply current, IN pin	$\label{eq:stars} \begin{array}{l} TS = open, \ V_{IN} = 6V, \ TTDM - no \ load \ on \ OUT \\ pin, \ V_{OUT} > V_{OUT(REG)}, \ IC \ enabled \end{array}$		0.8	1	mA
BATTERY CH	IARGER FAST-CHARGE					
V _{OUT(REG)}	Battery regulation voltage	$V_{IN} = 5.5V, I_{OUT} = 25mA, (V_{TS-45^{\circ}C} \le V_{TS} \le V_{TS-0^{\circ}C}, bq24040)$	4.16	4.2	4.23	V
V _{O_HT(REG)}	Battery hot regulation Voltage, bq24040	V_{IN} =5.5V, I_{OUT} =25mA, $V_{TS-60^{\circ}C} \le V_{TS} \le V_{TS-45^{\circ}C}$	4.02	4.06	4.1	V
I _{OUT(RANGE)}	Programmed Output "fast charge" current range	$\label{eq:VOUT(REG)} \begin{split} V_{OUT(REG)} &> V_{OUT} > V_{LOWV}; \ V_{IN} = 5V, \ ISET2=Lo, \\ R_{ISET} &= 675 \ to \ 10.8 k\Omega \end{split}$	10		800	mA
V _{DO(IN-OUT)}	Drop-Out, VIN – VOUT	Adjust VIN down until I_{OUT} = 0.5A, V_{OUT} = 4.15V, R_{ISET} = 675 , ISET2=Lo (adaptor mode); Tj \leq 100°C		325	500	mV
I _{OUT}	Output "fast charge" formula	$V_{OUT(REG)} > V_{OUT} > V_{LOWV}$; $V_{IN} = 5V$, ISET2=Lo	I	K _{ISET} /R _{ISET}		А
		$R_{ISET} = K_{ISET} / I_{OUT}$; 50 < IOUT < 800 mA	510	540	570	
KISET	Fast charge current factor	$R_{ISET} = K_{ISET} / I_{OUT}$; 25 < IOUT < 50 mA	480	527	600	AΩ
		$R_{ISET} = K_{ISET} / I_{OUT}$; 10 < IOUT < 25 mA	350	520	680	
PRECHARGE	- SET BY PRETERM PIN: bq24040; Int	ernally Set: bq24041				
V _{LOWV}	Pre-charge to fast-charge transition threshold		2.4	2.5	2.6	V
t _{DGL1(LOWV)}	Deglitch time on pre-charge to fast-charge transition			70		μs
t _{DGL2(LOWV)}	Deglitch time on fast-charge to pre-charge transition			32		ms
I _{PRE-TERM}	Refer to the Termination Section					
% _{PRECHG}	Pre-charge current, default setting	$V_{OUT} < V_{LOWV}$; $R_{ISET} = 1080\Omega$; bq24040: $R_{PRE-TERM} = High Z$; bq24041: Internally Fixed	18	20	22	%I _{OUT} cc
	Pre-charge current formula	$R_{PRE-TERM} = K_{PRE-CHG} \left(\Omega / \% \right) \times \mathscr{M}_{PRE-CHG} \left(\% \right)$	R _{PRE-TE}	RM/KPRE-CHG%		
		$ \begin{array}{l} V_{OUT} < V_{LOWV}, V_{IN} = 5V, R_{PRE-TERM} = 2k \ \text{to} \ 10k\Omega; \\ R_{ISET} = 1080\Omega \ , R_{PRE-TERM} = K_{PRE-CHG} \ \times \\ \% I_{FAST-CHG}, \text{where} \ \% I_{FAST-CHG} \ \text{is} \ 20 \ \text{to} \ 100\% \end{array} $	90	100	110	Ω/%
K _{PRE-CHG}	% Pre-charge Factor	$ V_{OUT} < V_{LOWV}, V_{IN} = 5V, R_{PRE-TERM} = 1k \text{ to } 2k\Omega; \\ R_{ISET} = 1080\Omega, R_{PRE-TERM} = K_{PRE-CHG} \times \\ \% I_{FAST-CHG}, \text{ where } \% I_{FAST-CHG} \text{ is } 10\% \text{ to } 20\% $	84	100	117	Ω/%
TERMINATIO	N – SET BY PRE-TERM PIN: bq24040; I	nternally Set: bq24041				
0/	Termination Threshold Current, default setting	V _{OUT} > V _{RCH} ; R _{ISET} = 1k; bq24040: R _{PRE-TERM} = High Z ; bq24041: Internally Fixed	9	10	11	%I _{OUT}
% _{TERM}	Termination Current Threshold Formula, bq24040	$R_{PRE-TERM} = K_{TERM} (\Omega/\%) \times \% TERM (\%)$	R _{PRE-}	TERM/ KTERM		
K _{TERM}	% Term Factor	$\label{eq:VOUT} \begin{array}{l} V_{OUT} > V_{RCH}, V_{IN} = 5V, R_{PRE-TERM} = 2k \mbox{ to } 10k\Omega \ ; \\ R_{ISET} = 750\Omega \ K_{TERM} \times \% l_{FAST-CHG}, \mbox{ where} \\ \% l_{FAST-CHG} \ is \ 10 \ to \ 50\% \end{array}$	182	200	216	Ω/%
INTERM		$ \begin{array}{l} V_{OUT} > V_{RCH}, \ V_{IN} = 5V, \ R_{PRE-TERM} = 1k \ to \ 2k\Omega \ ; \\ R_{ISET} = 750\Omega \ K_{TERM} \times \% lset, \ where \ \% lset \ is \ 5 \ to \ 10\% \end{array} $	174	199	224	\$2/ 70
I _{PRE-TERM}	Current for programming the term. and pre-chg with resistor. I _{Term-Start} is the initial PRE-TERM curent.	R _{PRE-TERM} = 2k, V _{OUT} = 4.15V	71	75	81	μA



ELECTRICAL CHARACTERISTICS (continued)

Over junction temperature range $0^{\circ}C \le T_{J} \le 125^{\circ}C$ and recommended supply voltage (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
%TERM	Termination current formula			R_{TERM}/K_{TERM}		%
t _{DGL(TERM)}	Deglitch time, termination detected			29		ms
I _{Term-Start}	Elevated PRE-TERM current for, t _{Term-Start} , during start of charge to prevent recharge of full battery,		80	85	92	μA
t _{Term-Start}	Elevated termination threshold initially active for $\ensuremath{t_{\text{Term-Start}}}$			1.25		min
RECHARGE C	OR REFRESH – bq24040					
V _{RCH}	Recharge detection threshold – Normal Temp	$V_{\text{IN}} = 5\text{V}, V_{\text{TS}} = 0.5\text{V}, V_{\text{OUT}} \text{: } 4.25\text{V} \rightarrow V_{\text{RCH}}$	V _{O(REG)} -0.120	V _{O(REG)} -0.095	V _{O(REG)} –0. 070	V
* RCH	Recharge detection threshold – Hot Temp	$V_{\text{IN}} = 5\text{V}, V_{\text{TS}} = 0.2\text{V}, V_{\text{OUT}} \text{: } 4.15\text{V} \rightarrow V_{\text{RCH}}$	V _{O_HT(REG)} -0.130	V _{O_HT(REG)} -0.105	V _{O_HT(REG)} -0.080	V
t _{DGL1(RCH)}	Deglitch time, recharge threshold detected	V_{IN} = 5V, V_{TS} = 0.5V, V_{OUT} : 4.25V \rightarrow 3.5V in 1µs; $t_{\text{DGL(RCH)}}$ is time to ISET ramp		29		ms
t _{DGL2(RCH)}	Deglitch time, recharge threshold detected in OUT-Detect Mode	V_{IN} = 5V, V_{TS} = 0.5V, V_{OUT} = 3.5V inserted; $t_{\text{DGL(RCH)}}$ is time to ISET ramp		3.6		ms
BATTERY DE	TECT ROUTINE – bq24040 (NOTE: In H	ot mode V _{O(REG)} becomes V _{O_HT(REG)})	T			
V _{REG-BD}	VOUT Reduced regulation during battery detect		V _{O(REG)} - 0.450	V _{O(REG)} -0.400	V _{O(REG)} - 350	V
I _{BD-SINK}	Sink current during V _{REG-BD}	$V_{IN} = 5V, V_{TS} = 0.5V$, Battery Absent	7		10	mA
t _{DGL(HI/LOW} REG)	Regulation time at V_{REG} or $V_{\text{REG-BD}}$			25		ms
V _{BD-HI}	High battery detection threshold	V_{IN} = 5V, V_{TS} = 0.5V, Battery Absent	V _{O(REG)} -0.150	V _{O(REG)} -0.100	V _{O(REG)} - 0.050	V
V _{BD-LO}	Low battery detection threshold	V_{IN} = 5V, V_{TS} = 0.5V, Battery Absent	V _{REG-BD} +0.50	V _{REG-BD} +0.1	V _{REG-BD} +0.15	V
BATTERY CH	IARGING TIMERS AND FAULT TIMERS					
t _{PRECHG}	Pre-charge safety timer value	Restarts when entering Pre-charge; Always enabled when in pre-charge.	1700	1940	2250	S
t _{MAXCH}	Charge safety timer value	Clears fault or resets at UVLO, TS/BAT_EN disable, OUT Short, exiting LOWV and Refresh	34000	38800	45000	S
BATTERY-PA	CK NTC MONITOR (Note 1); TS pin: bo	24040: 10k NTC	1			
INTC-10k	NTC bias current	$V_{TS} = 0.3V$	48	50	52	μA
INTC-DIS-10k	10k NTC bias current when Charging is disabled.	V _{TS} = 0V	27	30	34	μA
INTC-FLDBK-10k	INTC is reduced prior to entering TTDM to keep cold thermistor from entering TTDM	V _{TS} : Set to 1.525V	4	5	6.5	μA
V _{TTDM(TS)}	Termination and timer disable mode Threshold – Enter	$V_{TS}\!\!:$ 0.5V \rightarrow 1.7V; Timer Held in Reset	1550	1600	1650	mV
V _{HYS-TTDM(TS)}	Hysteresis exiting TTDM	$V_{TS}\!\!:1.7V\rightarrow0.5V\!;$ Timer Enabled		100		mV
V _{CLAMP(TS)}	TS maximum voltage clamp	V _{TS} = Open (Float)	1800	1950	2000	mV
tool (TTO: 1)	Deglitch exit TTDM between states			57		ms
^I DGL(TTDM)	Deglitch enter TTDM between states	INTC adjustment (90 to 10%; 45 to 6.6uS) takes		8		μs
V _{TS_I-FLDBK}	TS voltage where INTC is reduce to keep thermistor from entering TTDM	place near this spec threshold. V _{TS} : 1.425V \rightarrow 1.525V		1475		mV
C _{TS}	Optional Capacitance – ESD			0.22		μF
V _{TS-0°C}	Low temperature CHG Pending	Low Temp Charging to Pending; $V_{TS}{:}~1V \rightarrow 1.5V$	1205	1230	1255	mV
V _{HYS-0°C}	Hysteresis at 0°C	Charge pending to low temp charging; $V_{TS}{:}~1.5V \rightarrow 1V$		86		mV
		Normal charging to low temp charging;	765	790	815	mV
V _{TS-10°C}	Low temperature, half charge	$V_{TS}: 0.5V \rightarrow 1V$				
	Low temperature, half charge Hysteresis at 10°C			35		mV

Copyright © 2009, Texas Instruments Incorporated

SL整制AB發現W時及3997-FTMBER 2009



www.ti.com

ELECTRICAL CHARACTERISTICS (continued)

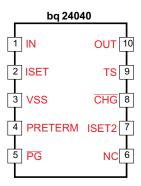
Over junction temperature range $0^{\circ}C \le T_{J} \le 125^{\circ}C$ and recommended supply voltage (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{HYS-45°C}	Hysteresis at 45°C	High temp charging to normal CHG; $V_{TS}: 0.2V \rightarrow 0.5V$		10.7		mV
V _{TS-60°C}	High temperature Disable	High temp charge to pending; V_{TS} : 0.2V \rightarrow 0.1V	170	178	186	mV
V _{HYS-60°C}	Hysteresis at 60°C	Charge pending to high temp CHG; V_{TS} : 0.1V \rightarrow 0.2V		11.5		mV
	Normal to Cold Operation; V_{TS} : 0.6V \rightarrow 1V			50		
t _{DGL(TS_10C)}	Deglitch for TS thresholds: 10C.	Cold to Normal Operation; V_{TS} : $1V \rightarrow 0.6V$		12		ms
t _{DGL(TS)}	Deglitch for TS thresholds: 0/45/60C.	Battery charging		30		ms
V _{TS-EN-10k}	Charge Enable Threshold, (10k NTC)	V_{TS} : 0V \rightarrow 0.175V;	80	88	96	mV
V _{TS-DIS_HYS-10k}	HYS below $V_{\text{TS-EN-10k}}$ to Disable, (10k NTC)	V_{TS} : 0.125V \rightarrow 0V;		12		mV
THERMAL RE	GULATION					
T _{J(REG)}	Temperature regulation limit			125		°C
T _{J(OFF)}	Thermal shutdown temperature			155		°C
T _{J(OFF-HYS)}	Thermal shutdown hysteresis			20		°C
BAT_EN , bq2	4041					
I BAT_EN	Current Sourced out of pin	$V _{\overline{BAT_{EN}}} < 1.4 V$	2.3	5	9	μA
VIL	Logic LOW enables charger		0		0.4	V
V _{IH}	Logic HIGH disables charger		1.1		6	V
V _{CLAMP}	Floating Clamp Voltage	Floating BAT_EN pin	1.4	1.6	1.8	V
LOGIC LIVELS	ON ISET2					
VIL	Logic LOW input voltage	Sink 8 µA			0.4	V
V _{IH}	Logic HIGH input voltage	Source 8 µA	1.4			V
IIL	Sink current required for LO	$V_{ISET2} = 0.4V$	2		9	μA
I _{IH}	Source current required for HI	$V_{ISET2} = 1.4V$	1.1		8	μA
V _{FLT}	ISET2 Float Voltage		575	900	1225	mV
AUTO START,	ASI AND ASO PINS, bq24041					
V _{ASIL}	Has 200k Internal Pull-down				0.4	V
V _{ASIH}			1.3			
V _{ASOL}	Auto Start Output Sinks 1mA				0.4	V
V _{ASOH}	Auto Start Input Sources 1mA		V _{OUT} - 0.4			
LOGIC LEVEL	S ON CHG AND PG	·				
V _{OL}	Output LOW voltage	I _{SINK} = 5 mA			0.4	V
ILEAK	Leakage current into IC	$V \overline{CHG} = 5V, V \overline{PG} = 5V$			1	μA



*暨椅99Q24040DSQT"供应商





bq2	24041
1 IN	OUT 10
2 ISET	BAT_EN 9
3 VSS	CHG 8
4 ASI	ISET2 7
5 PG	ASO 6

PIN FUNCTIONS

NAME	bq24040	bq24041	I/O	DESCRIPTION
IN	1	1	I	Input power, connected to external DC supply (AC adapter or USB port). Expected range of bypass capacitors 1μ F to 10μ F, connect from IN to V_{SS} .
OUT	10	10	0	Battery Connection. System Load may be connected. Average load should not be excessive, allowing battery to charge within the 10 hour safety timer window. Expected range of bypass capacitors 1μ F to 10μ F.
PRE-TERM	4	-	I	Programs the Current Termination Threshold (5 to 50% of lout which is set by ISET) and Sets the Pre-Charge Current to twice the Termination Current Level.
				Expected range of programming resistor is 1k to 10k Ω (2k: lpgm/10 for term; lpgm/5 for precharge)
ISET	2	2	I	Programs the Fast-charge current setting. External resistor from ISET to VSS defines fast charge current value. Range is 10.8k (50mA) to 675 Ω (800mA).
ISET2	7	7	I	Programming the Input/Output Current Limit for the USB or Adaptor source: bq24040 => High = 500mAmax, Low = ISET, FLOAT = 100mAmax. bq24041 => High = 410mAmax, Low = ISET, FLOAT = 100mAmax.
TS	9 ⁽¹⁾	-	I	Temperature sense pin connected to bq24040 -10k at 25°C NTC thermistor, in the battery pack. Floating TS Pin or pulling High puts part in TTDM "Charger" Mode and disable TS monitoring, Timers and Termination. Pulling pin Low disables the IC. If NTC sensing is not needed, connect this pin to VSS through an external 10 k Ω resistor. A 250k Ω from TS to ground will prevent IC entering TTDM mode when battery with thermistor is removed.
BAT_EN	_	9	Ι	Charge Enable Input (active low); 200k Internal Pull-down
VSS	3	3	-	Ground terminal
CHG	8	8	0	Low (FET on) indicates charging and Open Drain (FET off) indicates no Charging or Charge complete.
PG	5	5	0	Low (FET on) indicates the input voltage is above UVLO and the OUT (battery) voltage.
ASI	-	4	I	Auto start External input. Internal 200kΩ pull-down.
ASO	-	6	0	Auto Start Logic Output
NC	6	-	NA	Do not make a connection to this pin (for internal use) – Do not route through this pin
Thermal PAD and Package	Pad 2x2mm ²	Pad 2x2mm ²	_	There is an internal electrical connection between the exposed thermal pad and the VSS pin of the device. The thermal pad must be connected to the same potential as the VSS pin on the printed circuit board. Do not use the thermal pad as the primary ground input for the device. VSS pin must be connected to ground at all times

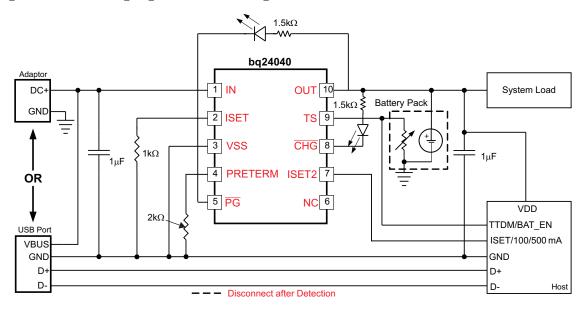
(1) Spins have different pin definitions

bq24040 bq24041 <u>SL型S物AB表表取研究DSOGTARTYSEPAGEPTEMBER 2009</u> TEXAS INSTRUMENTS

www.ti.com

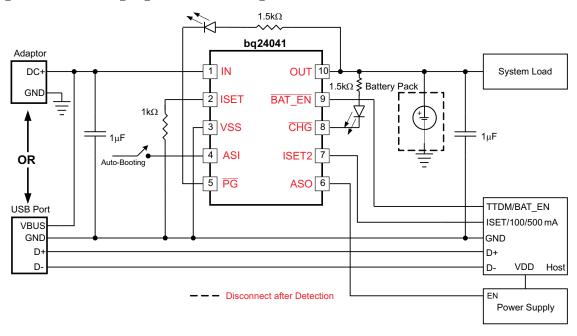
Typical Application Circuit: bq24041

 $I_{OUT_FAST_CHG} = 540mA$; $I_{OUT_PRE_CHG} = 108mA$; $I_{OUT_TERM} = 54mA$



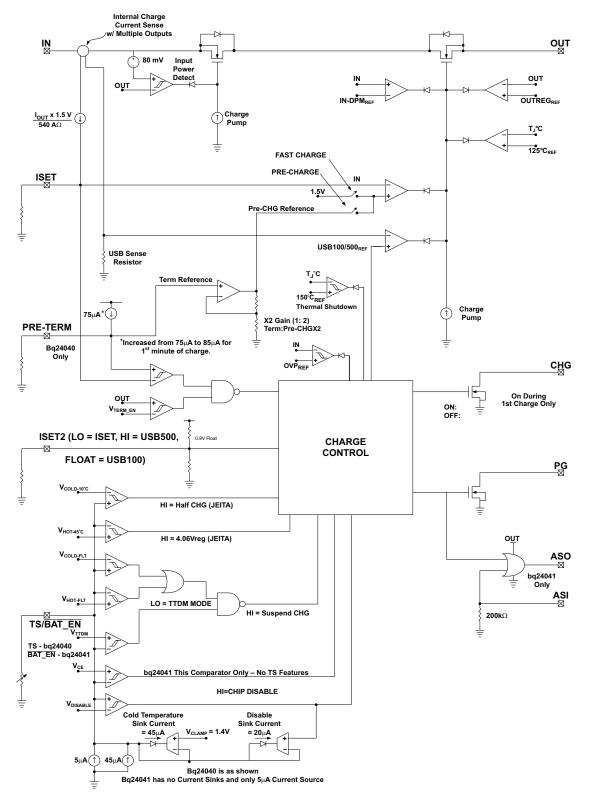
Typical Application Circuit: bq24041, with ASI and ASO

 $I_{OUT_FAST_CHG} = 540mA; I_{OUT_PRE_CHG} = 108mA; I_{OUT_TERM} = 54mA$





FUNCTIONAL BLOCK DIAGRAM



Copyright © 2009, Texas Instruments Incorporated

bq24040 bq24041 SL达器制AB设置在WB5D309TREWSED高FPTEMBER 2009

TYPICAL OPERATIONAL CHARACTERISTICS

SETUP: bq24040 typical applications schematic; $V_{IN} = 5V$, $V_{BAT} = 3.6V$ (unless otherwise indicated)

POWER UP, DOWN, OVP, DISABLE AND ENABLE WAVEFORMS

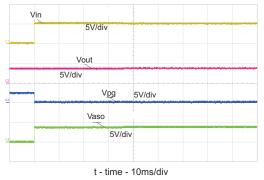


Figure 1. Power up Timing, bq24041

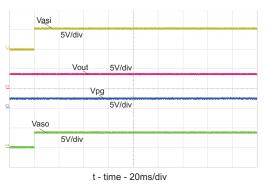


Figure 3. - ASI and OUT Power-up Timing - No Input, bq24041

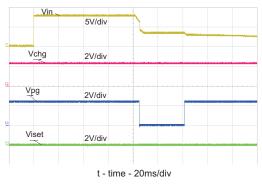


Figure 5. OVP 8V Adaptor - Hot Plug

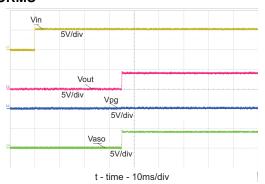


Figure 2. Power up Timing - No Battery or Load, bq24041

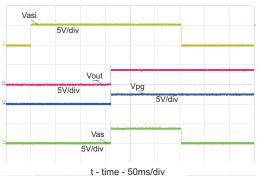
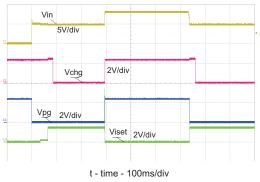
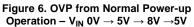


Figure 4. ASI and delayed OUT Power-up Timing - No Input, bq24041





INSTRUMENTS www.ti.com

EXAS

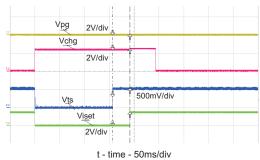


IC.

"暨街99Q24040DSQT"供应商

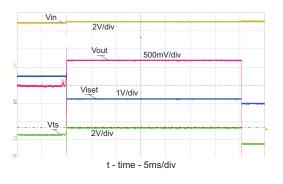
TYPICAL OPERATIONAL CHARACTERISTICS (continued)

SETUP: bq24040 typical applications schematic; V_{IN} = 5V, V_{BAT} = 3.6V (unless otherwise indicated)

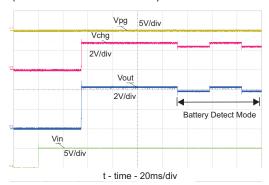


 $10k\Omega$ resistor from TS to GND. $10k\Omega$ is shorted to disable the









Fixed $10k\Omega$ resistor, between TS and GND.

Figure 8. Hot Plug Source w/No Battery – Battery Detection

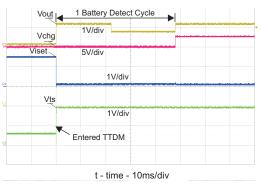
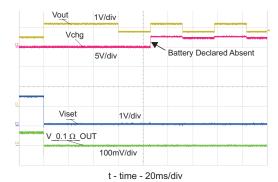


Figure 10. Battery Removal with OUT and TS Disconnect 1st, With 100 Ω Load



Continuous battery detection when not in TTDM.

Figure 11. Battery Removal with fixed TS = 0.5V

bq24040 bq24041 SL#S941Ap 9EBTEMBER 2009-REMISED SEPTEMBER 200



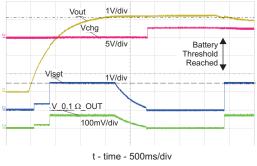
www.ti.com

SL整約4日發見研解的2009 TREWSED 8009

TYPICAL OPERATIONAL CHARACTERISTICS (continued)

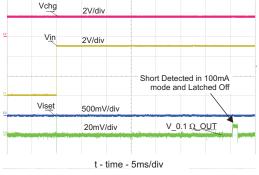
SETUP: bq24040 typical applications schematic; $V_{IN} = 5V$, $V_{BAT} = 3.6V$ (unless otherwise indicated)

PROTECTION CIRCUITS WAVEFORMS



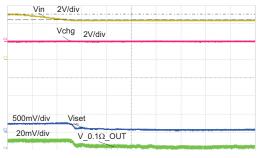
CH4: lout (1A/Div)Battery voltage swept from 0V to 4.25V to 3.9V.

Figure 12. Battery Charge Profile



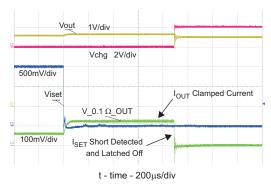
CH4: lout (0.2A/Div)

Figure 14. ISET Shorted Prior to USB Power-up



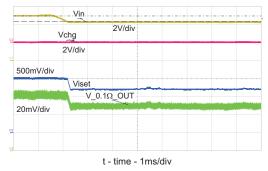
t - time - 500µs/div

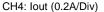
Figure 16. DPM – USB Current Limits – Vin Regulated to 4.4V



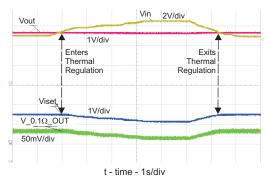
CH4: lout (1A/Div)

Figure 13. ISET Shorted During Normal Operation









The IC temperature rises to 125° C and enters thermal regulation. Charge current is reduced to regulate the IC at 125° C. VIN is reduced, the IC temperature drops, the charge current returns to the programmed value.

Figure 17. Thermal Reg. - Vin increases PWR/lout Reduced



4.212

4.21

4.208

4.206 4.204

4.202

4.2 4.198

4.196

4.5

V_{OUT} - Output Voltage DC - V

V_O@0°C

V_O @ 25°C

V_O @ 85°C

5

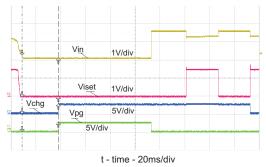
TYPICAL OPERATIONAL CHARACTERISTICS (continued)

SETUP: bq24040 typical applications schematic; $V_{IN} = 5V$, $V_{BAT} = 3.6V$ (unless otherwise indicated)

R_{OUT =} 100 Ω

6

6.5



Vin swept from 5V to 3.9V to 5V, Vbat = 4V

Figure 18. Entering and Exiting Sleep mode

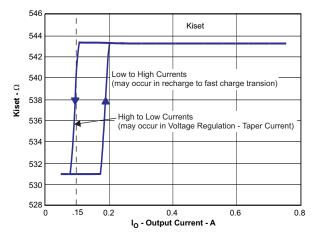
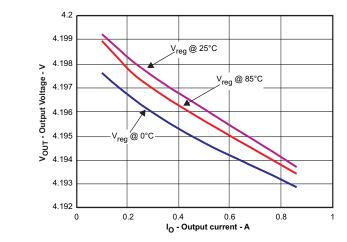
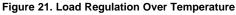


Figure 19. Kiset for Low and High Currents





5.5 V_I - Input Voltage DC - V



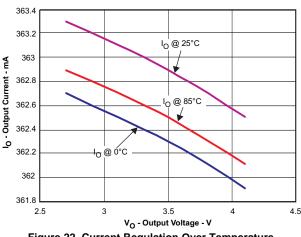


Figure 22. Current Regulation Over Temperature



www.ti.com

FUNCTIONAL GENERAL DESCRIPTION

The bq2404x is a highly integrate family of 2x2 single cell Li-Ion chargers. The charger can be used to charge a battery, power a system or both. The charger has three phases of charging: Pre-charge to recover a fully discharged battery, fast-charge constant current to supply the buck charge safely and voltage regulation to safely reach full capacity. The charger is very flexible, allowing programming of the fast-charge current and Pre-charge/Termination Current (bq24040 only). This charger is designed to work with a USB connection or Adaptor (DC out). The charger also checks to see if a battery is present.

The charger also comes with a full set of safety features: JEITA Temperature Standard (bq24040 only), Over-Voltage Protection, DPM-IN, Safety Timers, and ISET short protection. All of these features and more are described in detail below.

The charger is designed for a single power path from the input to the output to charge a single cell Li-Ion battery pack. Upon application of a 5VDC power source the ISET and OUT short checks are performed to assure a proper charge cycle.

If the battery voltage is below the LOWV threshold, the battery is considered discharged and a preconditioning cycle begins. The amount of precharge current can be programmed using the PRE-TERM pin which programs a percent of fast charge current (10 to 100%) as the precharge current. This feature is useful when the system load is connected across the battery "stealing" the battery current. The precharge current can be set higher to account for the system loading while allowing the battery to be properly conditioned. The PRE-TERM pin is a dual function pin which sets the precharge current level and the termination threshold level. The termination "current threshold" is always half of the precharge programmed current level.

Once the battery voltage has charged to the VLOWV threshold, fast charge is initiated and the fast charge current is applied. The fast charge constant current is programmed using the ISET pin. The constant current provides the bulk of the charge. Power dissipation in the IC is greatest in fast charge with a lower battery voltage. If the IC reaches 125°C the IC enters thermal regulation, slows the timer clock by half and reduce the charge current as needed to keep the temperature from rising any further. Figure 23 shows the charging profile with thermal regulation. Typically under normal operating conditions, the IC's junction temperature is less than 125°C and thermal regulation is not entered.

Once the cell has charged to the regulation voltage the voltage loop takes control and holds the battery at the regulation voltage until the current tapers to the termination threshold. The termination can be disabled if desired. The CHG pin is low (LED on) during the first charge cycle only and turns off once the termination threshold is reached, regardless if termination, for charge current, is enabled or disabled.

Further details are mentioned in the Operating Modes section.



DQ24040 bq24041 SLUS941A – SEPTEMBER 2009–REVISED SEPTEMBER 2009

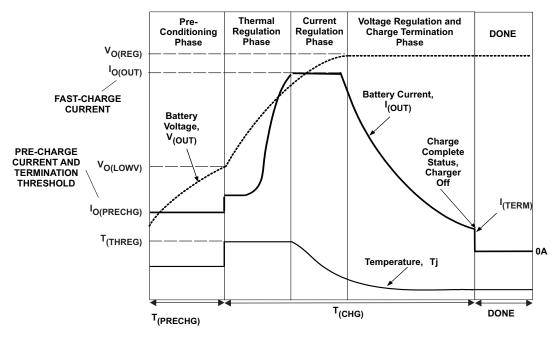


Figure 23. Charging Profile With Thermal Regulation

DETAILED FUNCTIONAL DESCRIPTION

Power-Down or Undervoltage Lockout (UVLO)

The bq2404x family is in power down mode if the IN pin voltage is less than UVLO. The part is considered "dead" and all the pins are high impedance. Once the IN voltage rises above the UVLO threshold the IC will enter Sleep Mode or Active mode depending on the OUT pin (battery) voltage.

Power-up

The IC is alive after the IN voltage ramps above UVLO (see sleep mode), resets all logic and timers, and starts to perform many of the continuous monitoring routines. Typically the input voltage quickly rises through the UVLO and sleep states where the IC declares power good, starts the qualification charge at 100mA, sets the input current limit threshold base on the ISET2 pin, starts the safety timer and enables the CHG pin. See Figure 24.

Sleep Mode

If the IN pin voltage is between than $V_{OUT}+V_{DT}$ and UVLO, the charge current is disabled, the safety timer counting stops (not reset) and the PG and CHG pins are high impedance. As the input voltage rises and the charger exits sleep mode, the PG pin goes low, the safety timer continues to count, charge is enabled and the CHG pin returns to its previous state. See Figure 25

New Charge Cycle

A new charge cycle is started when a good power source is applied, performing a chip disable/enable (TS pin/BAT_EN), exiting Termination and Timer Disable Mode (TTDM), detecting a battery insertion or the OUT voltage dropping below the VRCH threshold. The CHG pin is active low only during the first charge cycle, therefore exiting TTDM or a dropping below VRCH will not turn on the CHG pin FET, if the CHG pin is already high impedance.

Copyright © 2009, Texas Instruments Incorporated

TEXAS INSTRUMENTS

www.ti.com

_tbGL(TS1_IOC) Cold to Normal Normal Operation t < t_{bGL(TTDM)} ШXit tpgr(T⁺ Enter В Mode beration Normal 7 t < t_{DGL(IS)} tbgL(TS) Deratior Cold Dots Show Threshold Trip Points filowed by a deglitch time before transitioning into a new mode. (MDL(TTDM) t_{DGL(TS_IOC)} Cold ШX БО Mode Drawing Not to Scale Enter Cold Fault Cold Operation tDGL(TS) orma 1 ^tbGL(TS_IOC) Rising 1 I 1 1 I Disabled tbGL(TS) I 1 I TS) -tbGL(I 1 +tbgL(TS 4.06 V HOT erati 1 Oneration (ST l 🖠 4.06 V HOT Т Dperatic ¦₫ L Disabled I $V_{\rm SS}$ 1.8V + 45°C_{HYS} 45°C-DIS_{HYS} 10°C_{HYS} 60°C_{HYS} 0°C 10°C Ц LDO_{HYS} 0°C_{HYS} LDO 8 0°C

Figure 24. TS Battery Temperature Bias Threshold and Deglitch Timers



"暨特曾Q24040DSQT"供应商

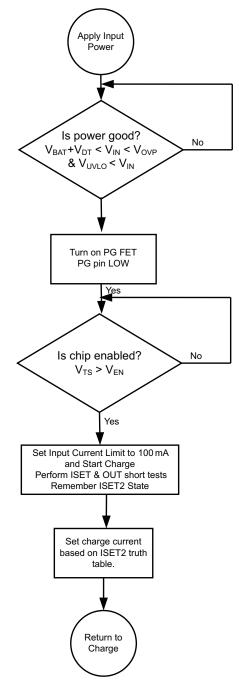


Figure 25. bq2404x Power-Up Flow Diagram

Overvoltage-Protection (OVP) – Continuously Monitored

If the input source applies an overvoltage, the pass FET, if previously on, turns off after a deglitch, t_{BLK(OVP)}. The timer ends and the CHG and PG pin goes to a high impedance state. Once the overvoltage returns to a normal voltage, the PG pin goes low, timer continues, charge continues and the CHG pin goes low after a 25ms deglitch. PG pin is optional on some packages

Copyright © 2009, Texas Instruments Incorporated

bq24040 bq24041 <u>SL鉴销AB發見振M转员3097 RFMSEP在FPTEMBER 2009</u>



Power Good Indication (PG)

After application of a 5V source, the input voltage rises above the UVLO and sleep thresholds (V_{IN} > V_{BAT} + V_{DT}), but is less than OVP (V_{IN} < V_{OVP}), then the PG FET turns on and provides a low impedance path to ground. See Figure 5, Figure 6, and Figure 18.

CHG Pin Indication

The charge pin has an internal open drain FET which is on (pulls down to V_{SS}) during the first charge only (independent of TTDM) and is turned off once the battery reaches voltage regulation and the charge current tapers to the termination threshold set by the PRE-TERM resistor.

The charge pin is high impedance in sleep mode and OVP (if PG is high impedance) and return to its previous state once the condition is removed.

Cycling input power, pulling the TS pin low and releasing or entering pre-charge mode causes the CHG pin to go reset (go low if power is good and a discharged battery is attached) and is considered the start of a first charge.

CHG and PG LED Pull-up Source

For host monitoring, a pull-up resistor is used between the "STATUS" pin and the V_{CC} of the host and for a visual indication a resistor in series with an LED is connected between the "STATUS" pin and a power source. If the CHG or PG source is capable of exceeding 7V, a 6.2V zener should be used to clamp the voltage. If the source is the OUT pin, note that as the battery changes voltage, and the brightness of the LEDs vary.

Charging State	CHG FET/LED							
1st Charge	ON							
Refresh Charge								
OVP	OFF							
SLEEP								
TEMP FAULT	ON for 1st Charge							
V _{IN} Power Good State	PG FET/LED							
UVLO								
SLEEP Mode	OFF							
OVP Mode								
Normal Input (V _{OUT} + V _{DT} < V _{IN} < V _{OUP})	ON							
PG is independe	nt of chip disable							

Auto Start-up (bq24041)

The auto start-up feature is an OR gate with two inputs; an internal power good signal (logic 1 when V_{IN} > V_{BAT} + V_{IN-DT}) and an external input from ASI pin (internal 100k pull-down). The ASO pin outputs a signal that can be used as a system boot signal. The OR gate is powered by the OUT pin and the OUT pin must be powered by an external source (battery or P/S) or via the IN pin for the ASO pin to deliver a logic High. The ASI and/or the internal power good signal have to be logic high for the ASO to be logic high. The ASI/ASO, OUT and PG signals are used in production testing to test the system without a battery.

IN-DPM (V_{IN}-DPM or IN-DPM)

The IN-DPM feature is used to detect an input source voltage that is folding back (voltage dropping), reaching its current limit due to excessive load. When the input voltage drops to the V_{IN-DPM} threshold the internal pass FET starts to reduce the current until there is no further drop in voltage at the input. This would prevent a source with voltage less than V_{IN-DPM} to power the out pin. This works well with current limited adaptors and USB ports as long as the nominal voltage is above 4.3V and 4.4V respectively. This is an added safety feature that helps protect the source from excessive loads.



*暨街90224040DSQT"供应商

OUT

The Charger's OUT pin provides current to the battery and to the system, if present. This IC can be used to charge the battery plus power the system, charge just the battery or just power the system (TTDM) assuming the loads do not exceed the available current. The OUT pin is a current limited source and is inherently protected against shorts. If the system load ever exceeds the output programmed current threshold, the output will be discharged unless there is sufficient capacitance or a charged battery present to supplement the excessive load.

ISET

An external resistor is used to Program the Output Current (50 to 800mA) and can be used as a current monitor.

 $R_{ISET} = K_{ISET} \div I_{OUT}$

(0)

Where:

I_{OUT} is the desired fast charge current;

 K_{ISET} is a gain factor found in the electrical specification

For greater accuracy at lower currents, part of the sense FET is disabled to give better resolution. Figure 19 shows the transition from low current to higher current. Going from higher currents to low currents, there is hysteresis and the transition occurs around 0.15A.

The ISET resistor is short protected and will detect a resistance lower than 340Ω. The detection requires at least 80mA of output current. If a "short" is detected, then the IC will latch off and can only be reset by cycling the power. The OUT current is internally clamped to a maximum current between 1.1A and 1.35A and is independent of the ISET short detection circuitry, as shown in Figure 27. Also, see Figure 13 and Figure 14.

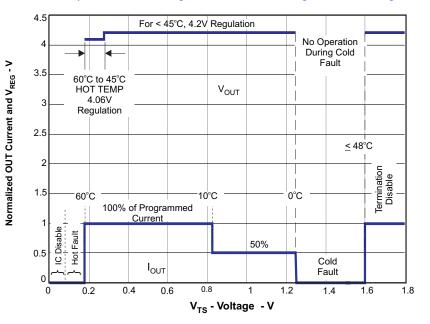


Figure 26. Operation Over TS Bias Voltage



www.ti.com

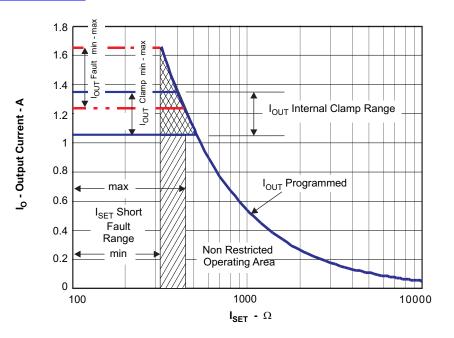


Figure 27. Programmed/Clamped Out Current

PRE_TERM – Pre-Charge and Termination Programmable Threshold, bq24040

Pre-Term is used to program both the pre-charge current and the termination current threshold. The pre-charge current level is a factor of two higher than the termination current level. The termination can be set between 5 and 50% of the programmed output current level set by ISET. If left floating the termination and pre-charge are set internally at 10/20% respectively. The pre-charge-to-fast-charge, V_{lowv} threshold is set to 2.5V.

 $R_{PRE-TERM} = \%Term \times K_{TERM} = \%Pre-CHG \times K_{PRE-CHG}$

(0)

Where:

%Term is the percent of fast charge current where termination occurs;

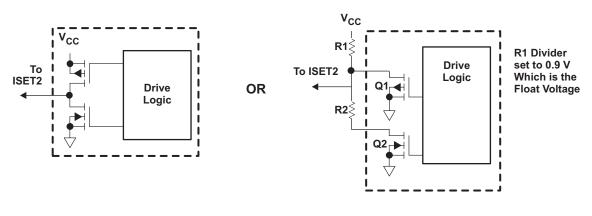
%Pre-CHG is the percent of fast charge current that is desired during precharge;

 K_{TERM} and $K_{PRE-CHG}$ are gain factors found in the electrical specifications.

ISET2

Is a 3-state input and programs the Input Current Limit/Regulation Threshold. A low will program a regulated fast charge current via the ISET resistor and is the maximum allowed input/output current for any ISET2 setting, Float will program a 100mA Current limit and High will program a 500mA Current limit.

Below are two configurations for driving the 3-state ISET2 pin:





TS (bq24040)

The TS pin is designed to follow the new JEITA temperature standard for Li-Ion batteries. There are now four thresholds, 60°C, 45°C, 10°C, and 0°C. Normal operation occurs between 10°C and 45°C. If between 0°C and 10°C the charge current level is cut in half and if between 45°C and 60°C the regulation voltage is reduced to 4.1Vmax, see Figure 26. The TS feature is implemented using an internal 50µA current source to bias the thermistor (designed for use with a 10k NTC β = 3370 (SEMITEC 103AT-2 or Mitsubishi TH05-3H103F) connected from the TS pin to V_{SS}. If this feature is not needed, a fixed 10k can be placed between TS and V_{SS} to allow normal operation. This may be done if the host is monitoring the thermistor and then the host would determine when to pull the TS pin low to disable charge.

The TS pin has two additional <u>features</u>, when the TS pin is pulled low or floated/driven high. A low disables charge (similar to a high on the BAT_EN feature) and a high puts the charger in TTDM.

Above 60°C or below 0°C the charge is disable. Once the thermistor reaches -10° C the TS current folds back to keep a cold thermistor (between -10° C and -50° C) from placing the IC in the TTDM mode. If the TS pin is pulled low into disable mode, the current is reduce to 30μ A, see Figure 24. Since the I_{TS} curent is fixed along with the temperature thresholds, it is not possible to use thermistor values other than the 10k NTC (at 25°C).

Termination and Timer Disable Mode (TTDM) -TS pin high

The battery charger is in TTDM when the TS pin goes high from removing the thermistor (removing battery pack/floating the TS pin) or by pulling the TS pin up to the TTDM threshold.

When entering TTDM, the 10 hour safety timer is held in reset and termination is disabled. A battery detect routine is run to see if the battery was removed or not. If the battery was removed then the CHG pin will go to its high impedance state if not already there. If a battery is detected the CHG pin does not change states until the current tapers to the termination threshold, where the CHG pin goes to its high impedance state if not already there (the regulated output will remain on).

The charging profile does not change (still has pre-charge, fast-charge constant current and constant voltage modes). This implies the battery is still charged safely and the current is allowed to taper to zero.

When coming out of TTDM, the battery detect routine is run and if a battery is detected, then a new charge cycle begins and the CHG LED turns on.

If TTDM is not desired upon removing the battery with the thermistor, one can add a 237k resistor between TS and V_{SS} to disable TTDM. This keeps the current source from driving the TS pin into TTDM. This creates 0.1°C error at hot and a 3°C error at cold.

Timers

The pre-charge timer is set to 30 minutes. The pre-charge current, can be programmed to off-set any system load, making sure that the 30 minutes is adequate.

The fast charge timer is fixed at 10 hours and can be increased real time by going into thermal regulation, IN-DPM or if in USB current limit. The timer clock slows by a factor of 2, resulting in a clock than counts half as fast when in these modes. If either the 30 minute or ten hour timer times out, the charging is terminated and the CHG pin goes high impedance if not already in that state. The timer is reset by disabling the IC, cycling power or going into and out of TTDM.

Termination

Once the OUT pin goes <u>above VRCH</u>, (reaches voltage regulation) and the current tapers down to the termination threshold, the CHG pin goes high impedance and a battery detect route is run to determine if the battery was removed or the battery is full. If the battery is present, the charge current will terminate. If the battery was removed along with the thermistor, then the TS pin is driven high and the charge enters TTDM. If the battery was removed and the TS pin is held in the active region, then the battery detect routine will continue until a battery is inserted.

Copyright © 2009, Texas Instruments Incorporated

bq24040 bq24041 <u>SL鉴销AB授型标准的39段TRIK并经合意</u>PTEMBER 2009



www.ti.com

Battery Detect Routine

The battery detect routine should check for a missing battery while keeping the OUT pin at a useable voltage. Whenever the battery is missing the CHG pin should be high impedance.

The battery detect routine is run when entering and exiting TTDM to verify if battery is present, or run all the time if battery is missing and not in TTDM. On power-up, if battery voltage is greater than V_{RCH} thereshold, a battery detect routine is run to determine if a battery is present.

The battery detect routine is disabled while the IC is in TTDM, or has a TS fault. See Figure 28for the Battery Detect Flow Diagram.

Refresh Threshold

After termination, if the OUT pin voltage drops to V_{RCH} (100mV below regulation) then a new charge is initiated, but the CHG pin remains at a high impedance (off).

Starting a Charge on a Full Battery

The termination threshold is raised by 14%, for the first minute of a charge cycle so if a full battery is removed and reinserted or a new charge cycle is initiated, that the new charge terminates (less than 1 minute). Batteries that have relaxed many hours may take several minutes to taper to the termination threshold and terminate charge.



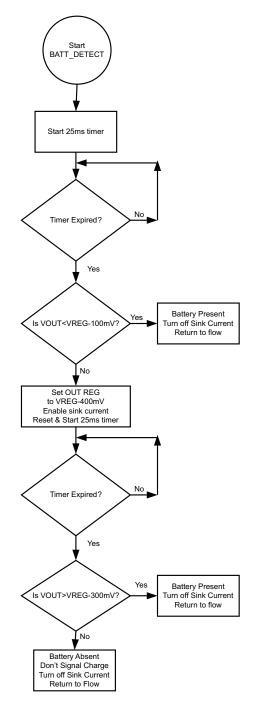
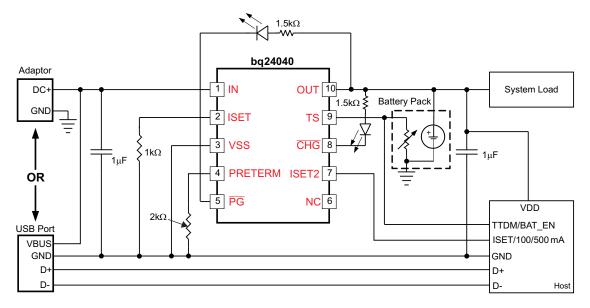


Figure 28. Battery Detect Routine (bq24040)



www.ti.com

bq24040 CHARGER APPLICATION DESIGN EXAMPLE



Requirements

- Supply voltage = 5 V
- Fast charge current: I_{OUT-FC} = 540 mA; ISET-pin 2
- Termination Current Threshold: %IOUT-FC = 10% of Fast Charge or ~54mA
- Pre-Charge Current by default is twice the termination Current or ~108mA
- TS Battery Temperature Sense = 10k NTC (103AT)

Calculations

Program the Fast Charge Current, ISET:

 $R_{ISET} = [K_{(ISET)} / I_{(OUT)}]$ from electrical characteristics table. . . $K_{(SET)} = 540A\Omega$ $R_{ISET} = [540A\Omega/0.54A] = 1.0 k\Omega$ Selecting the closest standard value, use a 1.0 k Ω resistor between ISET (pin 16) and Vss.

Program the Termination Current Threshold, ITERM:

 $R_{PRE-TERM} = K_{(TERM)} \times \%_{IOUT-FC}$ $R_{PRE-TERM} = 200\Omega/\% \times 10\% = 2k\Omega$ Selecting the closest standard value, use a 2 k Ω resistor between ITERM (pin 15) and Vss. One can arrive at the same value by using 20% for a pre-charge value (factor of 2 difference). $R_{PRE-TERM} = K_{(PRE-CHG)} \times \%_{IOUT-FC}$ $R_{PRE-TERM} = 100\Omega / \% \times 20\% = 2k\Omega$

TS Function (bq24040)

Use a 10k NTC thermistor in the battery pack (103AT).

To Disable the temp sense function, use a fixed 10k resistor between the TS (Pin 1) and Vss.



CHG and PG

LED Status: connect a 1.5k resistor in series with a LED between the OUT pin and the \overline{CHG} pin. Connect a 1.5k resistor in series with a LED between the OUT pin and the and PG pin.

Processor Monitoring: Connect a pull-up resistor between the processor's power rail and the CHG pin. Connect a pull-up resistor between the processor's power rail and the PG pin.

SELECTING IN AND OUT PIN CAPACITORS

In most applications, all that is needed is a high-frequency decoupling capacitor (ceramic) on the power pin, input and output pins. Using the values shown on the application diagram, is recommended. After evaluation of these voltage signals with real system operational conditions, one can determine if capacitance values can be adjusted toward the minimum recommended values (DC load application) or higher values for fast high amplitude pulsed load applications. Note if designed for high input voltage sources (bad adaptors or wrong adaptors), the capacitor needs to be rated appropriately. Ceramic capacitors are tested to 2x their rated values so a 16V capacitor may be adequate for a 30V transient (verify tested rating with capacitor manufacturer).

THERMAL PACKAGE

The bq2405x family is packaged in a thermally enhanced MLP package. The package includes a thermal pad to provide an effective thermal contact between the IC and the printed circuit board (PCB). The power pad should be directly connected to the VSS pin. Full PCB design guidelines for this package are provided in the application note entitled: QFN/SON PCB Attachment Application Note (SLUA271). The most common measure of package thermal performance is thermal impedance (θ_{JA}) measured (or modeled) from the chip junction to the air surrounding the package surface (ambient). The mathematical expression for θ_{JA} is:

$$\theta_{JA} = (T_J - T) / P$$

Where:

- T_J = chip junction temperature
- T = ambient temperature
- P = device power dissipation

Factors that can influence the measurement and calculation of θ_{JA} include:

- 1. Whether or not the device is board mounted
- 2. Trace size, composition, thickness, and geometry
- 3. Orientation of the device (horizontal or vertical)
- 4. Volume of the ambient air surrounding the device under test and airflow
- 5. Whether other surfaces are in close proximity to the device being tested

Due to the charge profile of Li-Ion batteries the maximum power dissipation is typically seen at the beginning of the charge cycle when the battery voltage is at its lowest. Typically after fast charge begins the pack voltage increases to 3.4V within the first 2 minutes. The thermal time constant of the assembly typically takes a few minutes to heat up so when doing maximum power dissipation calculations, 3.4V is a good minimum voltage to use. This is verified, with the system and a fully discharged battery, by plotting temperature on the bottom of the PCB under the IC (pad should have multiple vias), the charge current and the battery voltage as a function of time. The fast charge current will start to taper off if the part goes into thermal regulation.

The device power dissipation, P, is a function of the charge rate and the voltage drop across the internal PowerFET. It can be calculated from the following equation when a battery pack is being charged :

$$\mathsf{P} = [\mathsf{V}_{(\mathsf{IN})} - \mathsf{V}_{(\mathsf{OUT})}] \times \mathsf{I}_{(\mathsf{OUT})} + [\mathsf{V}_{(\mathsf{OUT})} - \mathsf{V}_{(\mathsf{BAT})}] \times \mathsf{I}_{(\mathsf{BAT})}$$

(0)

(0)

The thermal loop feature reduces the charge current to limit excessive IC junction temperature. It is recommended that the design not run in thermal regulation for typical operating conditions (nominal input voltage and nominal ambient temperatures) and use the feature for non typical situations such as hot environments or higher than normal input source voltage. With that said, the IC will still perform as described, if the thermal loop is always active.

Copyright © 2009, Texas Instruments Incorporated



www.ti.com

Leakage Current Effects on Battery Capacity

To determine how fast a leakage current on the battery will discharge the battery is an easy calculation. The time from full to discharge can be calculated by dividing the Amp-Hour Capacity of the battery by the leakage current. For a 0.75AHr battery and a 10 μ A leakage current (750mAHr/0.010mA = 75000 Hours), it would take 75k hours or 8.8 years to discharge. In reality the self discharge of the cell would be much faster so the 10 μ A leakage would be considered negliable.

Layout Tips

To obtain optimal performance, the decoupling capacitor from IN to GND (thermal pad) and the output filter capacitors from OUT to GND (thermal pad) should be placed as close as possible to the bq2405x, with short trace runs to both IN, OUT and GND (thermal pad).

- All low-current GND connections should be kept separate from the high-current charge or discharge paths from the battery. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.
- The high current charge paths into IN pin and from the OUT pin must be sized appropriately for the maximum charge current in order to avoid voltage drops in these traces
- The bq2405x family is packaged in a thermally enhanced MLP package. The package includes a thermal pad
 to provide an effective thermal contact between the IC and the printed circuit board (PCB); this thermal pad is
 also the main ground connection for the device. Connect the thermal pad to the PCB ground connection. It is
 best to use muntiply 10mil vias in the power pad of the IC and in close proxcimity to conduct the heat to the
 bottom ground plane. The bottom ground place should avoid traces that "cut off" the thermal path. The thiner
 the PCB the less temperature rise. The EVM PCB has a thickness of 0.031 inchs and uses 2 oz. (2.8mil
 thick) copper on top and bottom, and is a good example of optimal thermal performance.

REVISION HISTORY

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
BQ24040DSQR	ACTIVE	SON	DSQ	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
BQ24040DSQT	ACTIVE	SON	DSQ	10	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAF
BQ24041DSQR	ACTIVE	SON	DSQ	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAF
BQ24041DSQT	ACTIVE	SON	DSQ	10	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

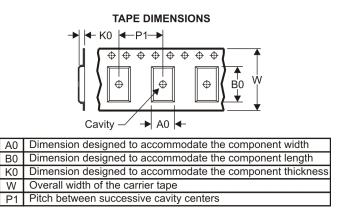
Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

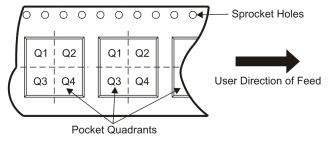
Texas Instruments 查询"BQ24040DSQT"供应商

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

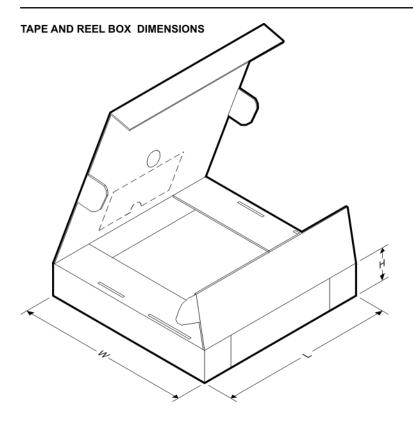


Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ24040DSQR	SON	DSQ	10	3000	179.0	8.4	2.2	2.2	1.2	4.0	8.0	Q2
BQ24040DSQT	SON	DSQ	10	250	179.0	8.4	2.2	2.2	1.2	4.0	8.0	Q2
BQ24041DSQR	SON	DSQ	10	3000	179.0	8.4	2.2	2.2	1.2	4.0	8.0	Q2
BQ24041DSQT	SON	DSQ	10	250	179.0	8.4	2.2	2.2	1.2	4.0	8.0	Q2



PACKAGE MATERIALS INFORMATION

12-Sep-2009

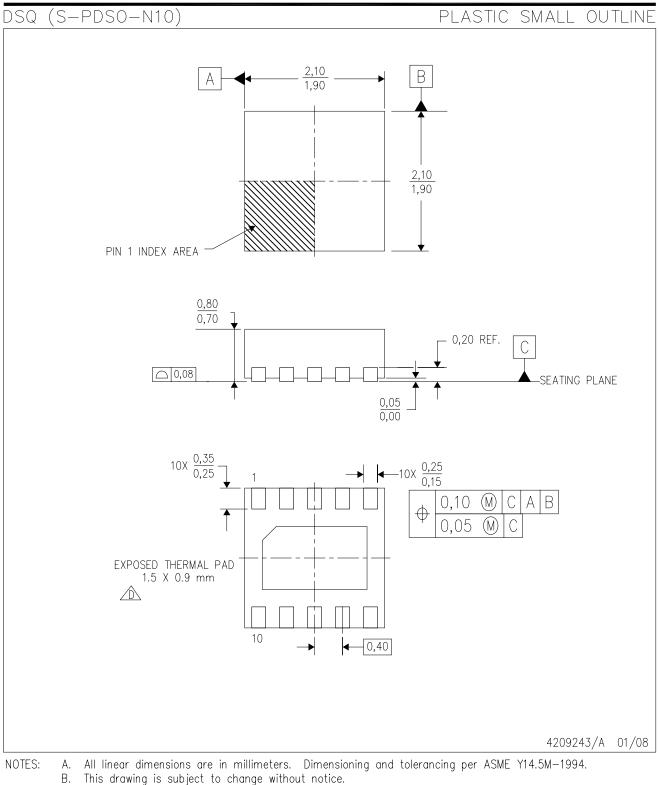


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ24040DSQR	SON	DSQ	10	3000	195.0	200.0	45.0
BQ24040DSQT	SON	DSQ	10	250	195.0	200.0	45.0
BQ24041DSQR	SON	DSQ	10	3000	195.0	200.0	45.0
BQ24041DSQT	SON	DSQ	10	250	195.0	200.0	45.0

MECHANICAL DATA

查询"BQ24040DSQT"供应商



- C. Small Outline No-Lead (SON) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.



查询"BQ24040DSQT"供应商

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DLP® Products	www.dlp.com	Broadband	www.ti.com/broadband
DSP	dsp.ti.com	Digital Control	www.ti.com/digitalcontrol
Clocks and Timers	www.ti.com/clocks	Medical	www.ti.com/medical
Interface	interface.ti.com	Military	www.ti.com/military
Logic	logic.ti.com	Optical Networking	www.ti.com/opticalnetwork
Power Mgmt	power.ti.com	Security	www.ti.com/security
Microcontrollers	microcontroller.ti.com	Telephony	www.ti.com/telephony
RFID	www.ti-rfid.com	Video & Imaging	www.ti.com/video
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2009, Texas Instruments Incorporated